

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10524458	WAAYERS, THOMAS FRANCISCUS
	<b>Examiner</b>	<b>Art Unit</b>
	TOAN M LE	2863

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
702	120,117	4/9/08	TL
700	53	4/9/08	TL
710	1,20,37,52,65	4/9/08	TL
714	30,724,726,727,729	4/9/08	TL
Above	Updated	12/24/08	TL
Above	Updated	6/7/09	TL
702	108,118,121	6/7/09	TL
700	1	6/7/09	TL
710	5,14,18,36,48,58	6/7/09	TL
714	735	6/7/09	TL

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
702/120,117; 700/53; 710/1,20,37,52,65; 714/30,724,726,727,729 (Test Controller Pin Register Input Output Bit Pattern Block Filter)	4/9/08	TL
Test Controller Pin Register Input Output Bit Pattern Block Filter	4/9/08	TL
East- See Search History Printout	4/9/08	TL
IEEE Xplore, NPL, Web search	4/9/08	TL
Above Updated	12/24/08	TL
East- See Search History Printout	12/24/08	TL
Above Updated	6/7/09	TL
702/108,118,121 (Test Controller Bypass Register Input Output Pin Bit Pattern Block Filter Update Evaluate)	6/7/09	TL
Test Controller Bypass Register Input Output Pin Bit Pattern Block Filter Update Evaluate	6/7/09	TL
East- See Search History Printout	6/7/09	TL

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
702	120	6/7/09	TL
710	48	6/7/09	TL